

UNISONIC TECHNOLOGIES CO., LTD

8N40-ML Power MOSFET

8.0A, 400V N-CHANNEL **POWER MOSFET**

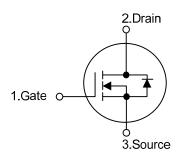
DESCRIPTION

The UTC 8N40-ML is a high voltage power MOSFET combines advanced planar MOSFET designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and high rugged avalanche characteristics. This power MOSFET is usually used in high speed switching applications of switching power supplies and adaptors.

FEATURES

- * $R_{DS(ON)} \le 0.75 \Omega$ @ V_{GS} =10V, I_D =4.0A
- * Fast switching capability
- * Avalanche energy tested
- * Improved dv/dt capability, high ruggedness

SYMBOL

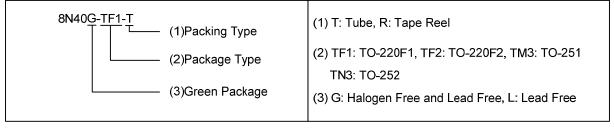


TO-220F1 TO-220F2 TO-251

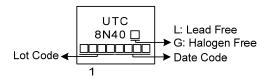
ORDERING INFORMATION

Ordering Number		Dookogo	Pin Assignment			Doolsing	
Lead Free	Halogen Free	Package	1	2	3	Packing	
8N40L-TF1-T	8N40G-TF1-T	TO-220F1	G	D	S	Tube	
8N40L-TF2-T	8N40G-TF2-T	TO-220F2	G	D	S	Tube	
8N40L-TM3-T	8N40G-TM3-T	TO-251	G	D	S	Tube	
8N40L-TN3-R	8N40G-TN3-R	TO-252	G	D	S	Tape Reel	

Pin Assignment: G: Gate S: Source Note: D: Drain



■ MARKING



■ ABSOLUTE MAXIMUM RATINGS (T_C=25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT	
Drain-Source Voltage		V_{DSS}	400	V	
Gate-Source Voltage		V_{GSS}	±30	V	
Continuous Drain Current		I _D	8	Α	
Pulsed Drain Current (Note 2)		I _{DM}	16	Α	
Avalanche Energy	Single Pulsed (Note 3)	E _{AS}	270	mJ	
Peak Diode Recovery dv/dt (Note 4)		dv/dt	3	V/ns	
Power Dissipation	TO-220F1/TO-220F2	Б	32	W	
	TO-251/TO-252	P_D	52	W	
Junction Temperature	unction Temperature		+150	°C	
Storage Temperature		T _{STG}	-55 ~ +150	°C	

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

- 2. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 3. L = 30mH, I_{AS} = 4.2A, V_{DD} = 50V, R_{G} = 25 Ω , Starting T_{J} = 25°C
- 4. $I_{SD} \le 8.0 \text{A}$, di/dt $\le 200 \text{A}/\mu\text{s}$, $V_{DD} \le \text{BV}_{DSS}$, Starting $T_J = 25^{\circ}\text{C}$

■ THERMAL DATA

PARAMETER		SYMBOL	RATINGS	UNIT	
Junction to Ambient	TO-220F1/TO-220F2	0	62.5	°C/W	
	TO-251/TO-252	θ_{JA}	110	°C/W	
Junction to Case	TO-220F1/TO-220F2	0	3.9	°C/W	
	TO-251/TO-252	θјс	2.4 (Note)	°C/W	

Note: Device mounted on FR-4 substrate P_C board, 2oz copper, with 1inch square copper plate.

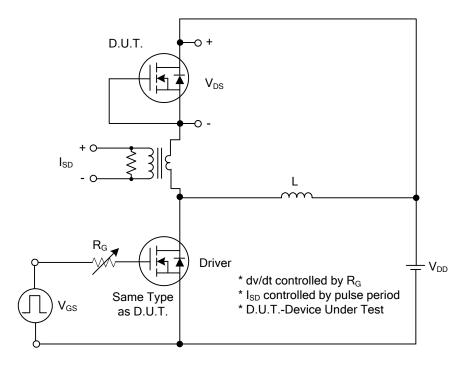
■ **ELECTRICAL CHARACTERISTICS** (T_J=25°C, unless otherwise specified)

PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS							
Drain-Source Breakdown Voltage		BV _{DSS}	V_{GS} =0V, I_D =250 μ A	400			V
Drain-Source Leakage Current		I_{DSS}	V _{DS} =400V, V _{GS} =0V			10	μΑ
Gate- Source Leakage Current	Forward	<u> </u>	V_{GS} =30V, V_{DS} =0V			100	nA
	Reverse	I _{GSS}	V_{GS} =-30V, V_{DS} =0V			-100	nA
ON CHARACTERISTICS							
Gate Threshold Voltage		$V_{GS(TH)}$	$V_{DS}=V_{GS}$, $I_D=250\mu A$	2.0		4.0	V
Static Drain-Source On-State Resistance		R _{DS(ON)}	V _{GS} =10V, I _D =4.0A			0.75	Ω
DYNAMIC CHARACTERISTICS		_				ā.	_
Input Capacitance	nput Capacitance				710		pF
Output Capacitance		Coss	V _{DS} =25V, V _{GS} =0V, f=1.0MHz		101		pF
Reverse Transfer Capacitance		C_{RSS}			12		pF
SWITCHING CHARACTERISTICS						_	
Total Gate Charge (Note 1)		Q_G	\\ -320\\ \\ -10\\ -8A		22.8		nC
Gate-Source Charge		Q_GS	V_{DS} =320V, V_{GS} =10V, I_{D} =8A I_{G} =1mA (Note 1, 2)		5.4		nC
Gate-Drain Charge		Q_GD	IG-IIIIA (Note 1, 2)		6.5		nC
Turn-On Delay Time (Note 1)		$t_{D(ON)}$			8		ns
Turn-On Rise Time		t_R	V_{DS} =100V, V_{GS} =10V, I_{D} =8A,		18		ns
Turn-Off Delay Time		$t_{D(OFF)}$	R _G =25Ω (Note 1, 2)		64		ns
Turn-Off Fall Time		t_{F}			28		ns
DRAIN-SOURCE DIODE CHARA	CTERISTICS	AND MAXII	MUM RATINGS				
Maximum Body-Diode Continuous Current		I_S				8	Α
Maximum Body-Diode Pulsed Current		I _{SM}				16	Α
Drain-Source Diode Forward Voltage (Note 1)		V_{SD}	I_S =8A , V_{GS} =0V			1.4	V
Reverse Recovery Time (Note 1)		t _{rr}	I_S =8A , V_{GS} =0V		228		ns
Reverse Recovery Charge		Q _{rr}	di/dt=100A/μs		4.0		μC

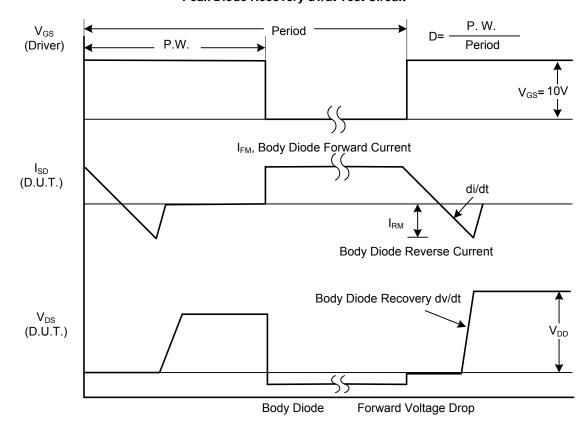
Notes: 1. Pulse Test: Pulse width \leq 300 μ s, Duty cycle \leq 2%.

^{2.} Essentially independent of operating temperature.

■ TEST CIRCUITS AND WAVEFORMS



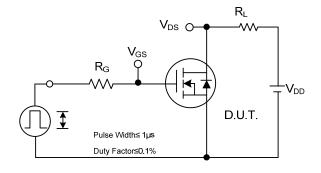
Peak Diode Recovery dv/dt Test Circuit

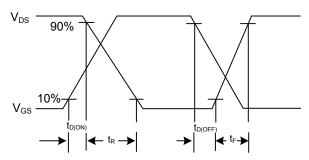


Peak Diode Recovery dv/dt Waveforms

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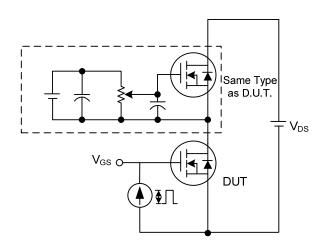
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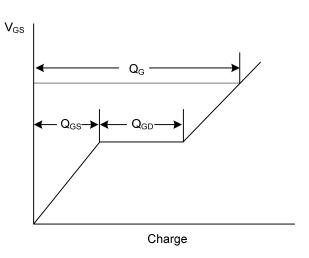




Switching Test Circuit

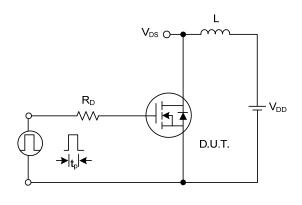
Switching Waveforms

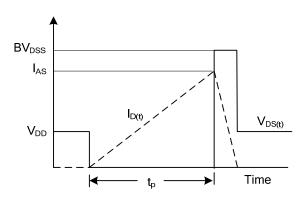




Gate Charge Test Circuit

Gate Charge Waveform





Unclamped Inductive Switching Test Circuit

Unclamped Inductive Switching Waveforms

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